

# **RADIO TEST REPORT**

S T S

# Report No: STS1906218W02

Issued for

**ITALCOM GROUP** 

1728Coral Way, Coral Gables, Miami, Florida, United States 33145(Zip code : 518048)

Product Name:	4G LTE
Brand Name:	NYX
Model Name:	ARGON
Series Model:	N/A
FCC ID:	YPVITALCOMARGON
Test Standard:	47 CFR Part 2, 27

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#### **TEST RESULT CERTIFICATION**

Applicant's Name	ITALCOM GROUP
Address	1728Coral Way, Coral Gables, Miami, Florida, United States 33145(Zip code : 518048)
Manufacture's Name	Shenzhen Tianruixiang Communication Equipment LIMITED
Address	Rm810, Block E, Taojindi Building, Tenglong Road, Longhua District, Shenzhen, China
Product description	
Product Name:	4G LTE
Brand Name	NYX
Model Name:	ARGON
Series Model	N/A
Test Standards	47 CFR Part 2, 27
Test Procedure:	KDB 971168 D01 v03r01, ANSI C63.26 2015

This device described above has been tested by STS, the test results show that the equipment under test (EUT) is in compliance with the FCC requirements. And it is applicable only to the tested sample identified in the report.

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Date of Test.....

Date (s) of performance of tests : 21 June 2019 ~ 27 June 2019

Date of Issue ..... 28 June 2019

Test Result ..... Pass

Testing Engineer

(Chris Chen)

Technical Manager

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APPROVAL 6

Authorized Signatory :

(Sunday Hu)

(Vita Li)

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# **Revision History**

Rev.	Issue Date	Report NO.	Effect Page	Contents
00	28 June 2019	STS1906218W02	ALL	Initial Issue



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# 1. TEST FACTORY & MEASUREMENT UNCERTAINTY

1.1 TEST FACTORY

Shenzhen STS Test Services Co., Ltd. Add.: 1/F., Building B, Zhuoke Science Park, No.190, Chongqing Road, Fuyong Street, Bao'an District, Shenzhen, Guangdong, China FCC test Firm Registration Number: 625569 A2LA Certificate No.: 4338.01

# 1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement  $y \pm U$ , where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

No.	Item	Uncertainty
1	RF output power, conducted	±0.71dB
2	Unwanted Emissions, conducted	±0.63dB
3	All emissions, radiated 30-200MHz	±3.43dB
4	All emissions, radiated 200MHz-1GHz	±3.57dB
5	All emissions, radiated>1G	±4.13dB
6	Conducted Emission (9KHz-150KHz)	±3.18dB
7	Conducted Emission (150KHz-30MHz)	±2.70dB





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# 2. GENERAL INFORMATION

#### 2.1 TECHNICAL SPECIFICATIONS AND REGULATIONS

# 2.1.1 PRODUCT DESCRIPTION

A major technical description of EUT is described as following:

Product Name:	4G LTE						
Trade Name	NYX						
Model Name	ARGON						
Series Model	N/A						
Model Difference	N/A						
	U.S. Bands:						
	LTE FDD Band 2 XLTE FDD Band 4						
Frequency Bands:	LTE FDD Band 5: LTE FDD Band 7:						
	LTE FDD Band 12: LTE FDD Band 13:						
	LTE FDD Band 17:						
SIM CARD:	Only support single SIM Card.						
Antenna:	PIFA Antenna						
Antenna gain:	LTE Band 4: -1dBi						
	Rated Voltage: 3.8V						
Battery parameter:	Charge Limit: 4.35V						
	Capacity: 2700mA						
Adaptary	Input: AC100-240V, 0.2A,50/60Hz						
Adapter:	Output: DC5V, 1000mA						
Extreme Vol. Limits:	DC 3.5 V to 4.35 V (Nominal DC3.8V)						
Extreme Temp.							
Tolerance:	-30℃ to +50℃						
Hardware version number:	NYX_ARGON_001						
Software version number:	ARGON_AMXNYX_V001R						



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# 2.1.2 PRODUCT SPECIFICATION SUBJECTIVE TO THIS STANDARD

Product Specification Subjective To This Standard						
Tx Frequency LTE Band 4:1710~1755MHz						
Rx Frequency LTE Band 4:2110~2155MHz						
Bandwidth	LTE Band 4: 1.4MHz / 3MHz / 5MHz / 10MHz / 15MHz /20MHz					
Maximum Output LTE Band 4: 22.05 dBm						
Power Limit						
Type of Modulation	QPSK /16QAM					



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# 2.1.3 EMISSION DESIGNATOR

LTE Band 4 BW(MHz)	Emission Designator (26dBc)QPSK	Emission Designator (26dBc)16QAM
1.4	1M33G7D	1M29W7D
3	3M00G7D	3M03W7D
5	5M37G7D	5M43W7D
10	9M89G7D	10M1W7D
15	15M9G7D	15M2W7D
20	20M0G7D	20M0W7D



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# 2.1.4 TEST CONFIGURATION OF EQUIPMENT UNDER TEST

Antenna port conducted and radiated test items listed below are performed according to KDB 971168 D01 v03r01 and ANSI C63.26 2015 Power Meas. License Digital Systems with maximum output power. Radiated measurements are performed by rotating the EUT in three different orthogonal test planes tofind the maximum emission. Remark:

1. The mark 'v'means that this configuration is chosen for testing

- 2. The mark '-'means that this bandwidth is not supported.
- 3. The device is investigated from 30MHz to 10 times of fundamental signal for radiated

ITEMS	Band		Bandwidt		Bandwidth (MHz)		Modulation		RB #		Test Channel				
		1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full	L	Μ	Н
Max. Output Power	4	v	v	v	v	v	v	V	v	v	v	v	v	v	v
Peak&Avera Ratio	4						v	V	v	v		v	v	v	v
26dB&99% Bandwidth	4	v	v	v	v	v	v	V	v			v	v	v	v
Conducted Band Edge	4	v	v	v	v	v	v	V	v	v		v	v	v	v
Conducted Spurious Emission	4	v	v	v	v	v	v	v	V	v			v	v	v
Frequency Stability	4				v			v				v		v	
E.R.P.& E.I.R.P.	4	v	v	v	v	v	v	v	v	v			v	v	v
Radiated Spurious Emission	4	v	v	v	v	v	v	v		v			v	v	v



# 2.1.5 RELATED SUBMITTAL(S) / GRANT (S)

This submittal(s) (test report) is intended for filing to comply with the 47 CFR Part 2, 24(E), 27

#### 2.1.6 SPECIAL ACCESSORIES

The battery and the charger, earphone supplied by the applicant were used as accessories and being tested with eut intended for fcc grant together.

#### 2.1.7 EUT CONFIGURATION

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

#### 2.1.8 EUT EXERCISE

The Transmitter was operated in the maximum output power mode through Communication Tester. The TX frequency was fixed which was for the purpose of the measurements.





# 2.1.9 CONFIGURATION OF EUT SYSTEM

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.



#### Table 2-1 Equipment Used in EUT System

Item	Equipment	Model No.	Serial No.	Note
N/A	N/A	N/A	N/A	N/A

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in <sup>C</sup>Length<sub>2</sub> column.

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#### 2.1.10 MEASUREMENT INSTRUMENTS

The radiated emission testing was performed according to the procedures of ANSI C63.26 2015 and FCC CFR 47 rules of 2.1046, 2.1047, 2.1049, 2.1051, 2.1053, 2.1055, 2.1057. Radiation Test equipment

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until		
Test Receiver	R&S	ESCI	101427	2018.10.13	2019.10.12		
Signal Analyzer	Agilent	N9020A	MY51110105	2019.03.02	2020.03.01		
Wireless Communications Test Set	R&S	CMW 500	133884	2019.03.02	2020.03.01		
Bilog Antenna	TESEQ	CBL6111D	34678	2017.11.02	2020.11.1		
Horn Antenna	SCHWARZBECK	ZBECK BBHA 9120D(1201) 9120D-1343		2018.10.19	2021.10.18		
SHF-EHF Horn Antenna (18G-40GHz)	A-INFO	LB-180400-KF	J211020657	2018.03.11	2021.03.10		
Pre-Amplifier(0.1M-3GHz)	EM	EM330	060665	2018.10.13	2019.10.12		
Pre-Amplifier (1G-18GHz)	SKET	LNPA-01018G-45	SK2018080901	2018.10.13	2019.10.12		
turn table	EM	SC100_1	60531	N/A	N/A		
Antenna mast	EM	SC100	N/A	N/A	N/A		
Temperature & Humidity	HH660	Mieo	N/A	2018.10.11	2019.10.10		
Test SW	BULUN	BL410-E/18.905					

#### **RF** Connected Test

Kind of Equipment	Manufacturer	Manufacturer Type No. Serial No.			Calibrated until	
Universal Radio communication tester	R&S	CMU200	11764	2018.10.13	2019.10.12	
Wireless Communications Test Set	R&S	CMW 500	133884	2019.03.02	2020.03.01	
Signal Analyzer	Agilent	N9020A	MY49100060	2018.10.13	2019.10.12	
Temperature & Humidity	HH660	Mieo	N/A	2018.10.11	2019.10.10	
Test SW	FARAD	LZ-RF /LzRf-3A3				

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#### 2.1.11 MEASUREMENT RESULTS EXPLANATION EXAMPLE

For all conducted test items:

The offset level is set in the spectrum analyzer to compensate the RF cable loss and attenuator factorbetween EUT conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level is exactly the EUT RF output level.

The spectrum analyzer offset is derived from RF cable loss and attenuator factor.

Offset = RF Cable Loss + Attenuator Factor.



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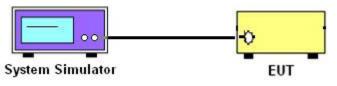
# 3. CONDUCTED OUTPUT POWER

3.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

#### 3.1.1 MEASUREMENT METHOD

A system simulator was used to establish communication with the eut. Its parameters were set to force the eut transmitting at maximum output power. The measured power in the radio frequency on the transmitter output terminals shall be reported. Configuration follows KDB 971168 D01 v03r01.

#### 3.1.2 TEST SETUP



#### 3.1.3 TEST PROCEDURES

- 1. The transmitter output port was connected to system simulator.
- 2. Set EUT at maximum power through the system simulator.
- 3. Select lowest/middle/highest channels for each band and different modulation.
- 4. Measure and record the power level from the system simulator.



#### 3.1.4 TEST RESULTS

LTE Band 4 Maximum Average Power [dBm]											
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest					
1.4	1	0		21.76	21.81	21.85					
1.4	1	2		21.51	21.53	21.56					
1.4	1	5		21.24	21.3	21.28					
1.4	3	0	QPSK	20.98	21.08	21.01					
1.4	3	1		20.72	20.82	20.77					
1.4	3	2		20.5	20.6	20.48					
1.4	6	0		20.26	20.32	20.26					
1.4	1	0		21.53	21.6	21.56					
1.4	1	2		21.25	21.33	21.29					
1.4	1	5		21.02	21.05	20.99					
1.4	3	0	16-QAM	20.74	20.83	20.7					
1.4	3	1		20.52	20.59	20.41					
1.4	3	2		20.22	20.36	20.17					
1.4	6	0		19.93	20.15	19.94					
3	1	0		21.89	21.92	21.87					
3	1	7		21.63	21.63	21.57					
3	1	14		21.37	21.35	21.36					
3	8	0	QPSK	21.1	21.09	21.11					
3	8	4		20.87	20.86	20.82					
3	8	7		20.62	20.57	20.53					
3	15	0		20.34	20.3	20.32					
3	1	0		21.63	21.66	21.64					
3	1	7		21.34	21.41	21.42					
3	1	14	16-QAM	21.13	21.19	21.22					
3	8	0		20.86	20.9	20.93					
3	8	4		20.6	20.68	20.68					
3	8	7		20.39	20.42	20.45					
3	15	0		20.16	20.2	20.19					

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LTE Band 4 Maximum Average Power [dBm]											
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest					
5	1	0		21.95	21.9	21.79					
5	1	12		21.74	21.69	21.58					
5	1	24		21.54	21.48	21.38					
5	12	0	QPSK	21.3	21.19	21.1					
5	12	6		21.06	20.93	20.84					
5	12	11		20.8	20.72	20.56					
5	25	0		20.54	20.5	20.35					
5	1	0		21.73	21.7	21.51					
5	1	12		21.52	21.42	21.23					
5	1	24		21.22	21.21	21.01					
5	12	0	16-QAM	20.93	20.94	20.79					
5	12	6		20.64	20.73	20.52					
5	12	11		20.38	20.5	20.29					
5	25	0		20.11	20.21	20					
10	1	0		21.83	21.89	21.92					
10	1	24		21.61	21.65	21.69					
10	1	49		21.38	21.4	21.43					
10	25	0	QPSK	21.12	21.1	21.19					
10	25	12		20.85	20.87	20.9					
10	25	24		20.64	20.61	20.65					
10	50	0		20.37	20.33	20.35					
10	1	0		21.58	21.65	21.63					
10	1	24		21.31	21.44	21.43					
10	1	49	16-QAM	21.11	21.15	21.2					
10	25	0		20.81	20.93	21					
10	25	12		20.55	20.73	20.72					
10	25	24		20.28	20.44	20.51					
10	50	0		20	20.23	20.29					

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LTE Band 4 Maximum Average Power [dBm]											
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest					
15	1	0		21.86	21.94	21.91					
15	1	37		21.6	21.66	21.66					
15	1	74		21.37	21.38	21.44					
15	36	0	QPSK	21.13	21.1	21.17					
15	36	18		20.84	20.87	20.88					
15	36	39		20.56	20.58	20.63					
15	75	0		20.28	20.34	20.42					
15	1	0		21.64	21.66	21.64					
15	1	38		21.41	21.4	21.41					
15	1	75		21.2	21.15	21.15					
15	36	0	16-QAM	20.97	20.91	20.85					
15	36	18		20.7	20.69	20.64					
15	36	39		20.49	20.46	20.38					
15	75	0		20.25	20.24	20.13					
20	1	0		22.03	21.97	22.05					
20	1	49		21.8	21.71	21.84					
20	1	99		21.57	21.45	21.6					
20	50	0	QPSK	21.3	21.2	21.39					
20	50	24		21.02	20.93	21.15					
20	50	49		20.81	20.65	20.86					
20	100	0		20.57	20.39	20.61					
20	1	0		21.82	21.72	21.77					
20	1	49		21.54	21.43	21.55					
20	1	99	16-QAM	21.32	21.19	21.31					
20	50	0		21.06	20.92	21.04					
20	50	24		20.79	20.72	20.83					
20	50	49		20.53	20.43	20.55					
20	100	0		20.31	20.2	20.34					

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# 4. PEAK-TO-AVERAGE RATIO

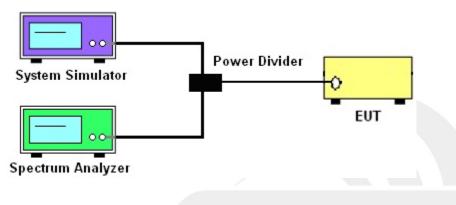
#### 4.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

#### 4.1.1 MEASUREMENT METHOD

Use one of the procedures presented in 4.1 to measure the total peak power and record as PPk. Use one of the applicable procedures presented 4.2 to measure the total average power and record as PAvg. Both the peak and average power levels must be expressed in the same logarithmic units (e.g., dBm). Determine the PAPR from:

PAPR (dB) = PPk (dBm) - PAvg (dBm).

#### 4.1.2 TEST SETUP



#### 4.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01 v03r01 Section 5.7.2 and ANSI C63.26 2015 Section 5.2.3.4
- 2. The EUT was connected to spectrum and system simulator via a power divider
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the peak and average power of the spectrum analyzer
- 5. Record the deviation as Peak to Average Ratio.

		LTE									
LTE BW	1.4M	3M	5M	10M	15M	20M					
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz					
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz					
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz					
Detector	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG					
Trace	Max	Max	Max	Max	Max	Max					
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto					



#### 4.1.4 TEST RESULTS

		LTE Band 4 PAR	[dBm]		
BW [MHz]	RB Size	Modulation	Lowest	Middle	Highest
N/A	N/A	N/A	P-A	P-A	P-A
20	1	QPSK	4.64	4.35	4.74
20	100	N/A	5.22	5.21	5.24
20	1	16-QAM	5.11	5.35	5.49
20	100	N/A	5.97	5.98	6.08
	Limit			≤13dBm	

Note: Test chart See Appendix D



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# 5. RADIATED POWER AND EFFECTIVE ISOTROPIC RADIATED POWER

#### 5.1 DESCRIPTION OF THE ERP/EIRP MEASUREMENT

#### 5.1.1 MEASUREMENT METHOD

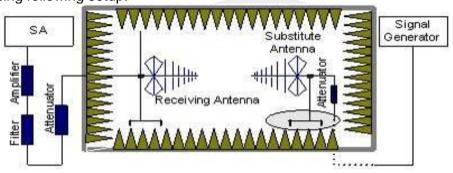
Effective radiated power output measurements by substitution method according to ANSI C63.26 2015, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas. License Digital Systems. Mobile and portable (hand-held) stations operating are limited to average ERP, Equivalent isotropic radiated power output measurements by substitution method according to ANSI C63.26 2015, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas. Power Meas, Mobile and portable (hand-held) stations operating are limited to average EIRP.

#### 5.1.2 TEST SETUP

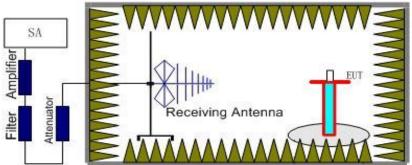
The procedure of radiated spurious emissions is as follows:

a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx ( dBuV ) +CL ( dB ) +SA ( dB ) +Gain ( dBi ) -107 ( dBuV to dBm ) The SA

is calibrated using following setup.



b) EUT was placed on a 1.5m non-conductive stand at a 3 m test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 m from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic measured with peak detector and 1MHz bandwidth.



Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below: Power=PMea+ARpl

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#### 5.1.3 TEST PROCEDURES

1. The testing follows FCC KDB 971168 D01v03r01 Section 5.6 and ANSI C63.26 2015 Section 5.2.

2. The EUT was placed on a non-conductive rotating platform 1.5 meters high in a semi-anechoic chamber. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and a spectrum analyzer with Peak detector.

3. During the measurement, the system simulator parameters were set to force the EUTtransmitting at maximum output power. The maximum emission was recorded from analyzer power level (LVL) from the 360 degrees rotation of the turntable and the test antenna raised and lowered over a range from 1 to 4 m in both horizontally and vertically polarized orientations.

4. Effective Isotropic Radiated Power (EIRP) was measured by substitution method according to ANSI C63.26 2015. The EUT was replaced by dipole antenna (substitution antenna) at same location and then a known power from S.G. was applied into the dipole antenna through a Tx cable, and then recorded the maximum Analyzer reading through raised and lowered the test antenna. The correction factor (in dB) = S.G. - Tx Cable loss + Substitution antenna gain -Analyzer reading. Then the EUT's EIRP was calculated with the correction factor, EIRP/ERP= LVL +Correction factor

5. RB Set greater than bandwidth, VB Set spectrum analyzer Maximum support.



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# 5.1.4 TEST RESULTS

Note: Test is divided into three directions, X/Y/Z. X pattern for the worst.

			Radiate	ed Power (B	EIRP) for	LTE Ba	nd 4 / 1.4M				
		RB				Re	esult				
Modulation	NB		Channel	S	Cable	Gain	PMeas	Polarization	Conclusion		
Siz	Size	Offset		G.Level (dBm)	loss	(dBi)	E.R.P(dBm)	Of Max. ERP			
	1	0	Lowest	11.38	2.35	10.13	19.16	Horizontal	Pass		
	1	0	Middle	11.21	2.36	10.16	19.01	Horizontal	Pass		
QPSK	1	0	Highest	11.29	2.37	10.22	19.14	Horizontal	Pass		
QFSN	1	0	Lowest	12.75	2.35	10.13	<mark>20.53</mark>	Vertical	Pass		
	1	0	Middle	12.61	2.36	10.16	20.41	Vertical	Pass		
	1	0	Highest	12.68	2.37	10.22	20.53	Vertical	Pass		
	1	0	Lowest	11.02	2.35	10.13	18.80	Horizontal	Pass		
	1	0	Middle	11.2	2.36	10.16	19.00	Horizontal	Pass		
16QAM	1	0	Highest	11.09	2.37	10.22	18.94	Horizontal	Pass		
IOQAIVI	1	0	Lowest	12.39	2.35	10.13	20.17	Vertical	Pass		
	1	0	Middle	12.55	2.36	10.16	<mark>20.35</mark>	Vertical	Pass		
	1	0	Highest	12.49	2.37	10.22	20.34	Vertical	Pass		
Limit		EIRP<1W=30dBm									



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			Radiate	ed Power (	EIRP) fo	r LTE Ba	and 4 / 3M				
		RB			Result						
Modulation		λD	Channel	S	Cable	Gain	PMeas	Polarization	Conclusion		
	Size	Offset	onamor	G.Level loss		(dBi)	E.R.P(dBm)	Of Max. ERP			
	1	0	Lowest	11.43	2.35	10.13	19.21	Horizontal	Pass		
	1	0	Middle	11.41	2.36	10.16	19.21	Horizontal	Pass		
QPSK	1	0	Highest	11.33	2.37	10.22	19.18	Horizontal	Pass		
QFSK	1	0	Lowest	12.76	2.35	10.13	20.54	Vertical	Pass		
	1	0	Middle	12.75	2.36	10.16	20.55	Vertical	Pass		
	1	0	Highest	12.73	2.37	10.22	<mark>20.58</mark>	Vertical	Pass		
	1	0	Lowest	11.17	2.35	10.13	18.95	Horizontal	Pass		
	1	0	Middle	11.24	2.36	10.16	19.04	Horizontal	Pass		
16QAM	1	0	Highest	11.23	2.37	10.22	19.08	Horizontal	Pass		
TOQAIN	1	0	Lowest	12.62	2.35	10.13	20.40	Vertical	Pass		
	1	0	Middle	12.65	2.36	10.16	<mark>20.45</mark>	Vertical	Pass		
	1	0	Highest	12.54	2.37	10.22	20.39	Vertical	Pass		
Limit		EIRP<1W=30dBm									

			Radiate	ed Power (	EIRP) fo	r LTE Ba	and 4 / 5M			
		RB				R	esult			
Modulation	RB		Channel	S	Cable	Gain	PMeas	Polarization	Conclusion	
Size	Size	Offset	onanner	G.Level (dBm)	loss	(dBi)	E.R.P(dBm)	Of Max. ERP	Condition	
	1	0	Lowest	11.57	2.35	10.13	19.35	Horizontal	Pass	
	1	0	Middle	11.32	2.36	10.16	19.12	Horizontal	Pass	
QPSK	1	0	Highest	11.22	2.37	10.22	19.07	Horizontal	Pass	
QFOR	1	0	Lowest	12.88	2.35	10.13	<mark>20.66</mark>	Vertical	Pass	
	1	0	Middle	12.74	2.36	10.16	20.54	Vertical	Pass	
	1	0	Highest	12.68	2.37	10.22	20.53	Vertical	Pass	
	1	0	Lowest	11.11	2.35	10.13	18.89	Horizontal	Pass	
	1	0	Middle	11.26	2.36	10.16	19.06	Horizontal	Pass	
16QAM	1	0	Highest	10.98	2.37	10.22	18.83	Horizontal	Pass	
TOQAIVI	1	0	Lowest	12.59	2.35	10.13	20.37	Vertical	Pass	
	1	0	Middle	12.7	2.36	10.16	<mark>20.50</mark>	Vertical	Pass	
	1	0	Highest	12.34	2.37	10.22	20.19	Vertical	Pass	
Limit		EIRP<1W=30dBm								

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			Radiate	d Power (E	EIRP) for	LTE Ba	and 4 / 10M				
		RB			Result						
Modulation	ſ	1D	Channel	S	Cable	Gain	PMeas	Polarization	Conclusion		
modulation	Size	Offset		G.Level (dBm)	loss	(dBi)	E.R.P(dBm)	Of Max. ERP	Conordoron		
	1	0	Lowest	11.34	2.35	10.13	19.12	Horizontal	Pass		
	1	0	Middle	11.31	2.36	10.16	19.11	Horizontal	Pass		
QPSK	1	0	Highest	11.45	2.37	10.22	19.30	Horizontal	Pass		
QFSK	1	0	Lowest	12.71	2.35	10.13	20.49	Vertical	Pass		
	1	0	Middle	12.71	2.36	10.16	20.51	Vertical	Pass		
	1	0	Highest	12.85	2.37	10.22	<mark>20.70</mark>	Vertical	Pass		
	1	0	Lowest	11.07	2.35	10.13	18.85	Horizontal	Pass		
	1	0	Middle	11.25	2.36	10.16	19.05	Horizontal	Pass		
16QAM	1	0	Highest	11.11	2.37	10.22	18.96	Horizontal	Pass		
IOQAIVI	1	0	Lowest	12.44	2.35	10.13	20.22	Vertical	Pass		
	1	0	Middle	12.6	2.36	10.16	<mark>20.40</mark>	Vertical	Pass		
	1	0	Highest	12.45	2.37	10.22	20.30	Vertical	Pass		
Limit		EIRP<1W=30dBm									

			Radiate	d Power (E	EIRP) for	LTE Ba	and 4 / 15M				
		RB				Re	esult				
Modulation			Channel	S	Cable	Gain	PMeas	Polarization	Conclusion		
modulation	Size	Offset		G.Level loss (dBm)		(dBi)	E.R.P(dBm)	Of Max. ERP	Conolación		
	1	0	Lowest	11.38	2.35	10.13	19.16	Horizontal	Pass		
	1	0	Middle	11.46	2.36	10.16	19.26	Horizontal	Pass		
QPSK	1	0	Highest	11.22	2.37	10.22	19.07	Horizontal	Pass		
QFOR	1	0	Lowest	12.74	2.35	10.13	20.52	Vertical	Pass		
	1	0	Middle	12.9	2.36	10.16	<mark>20.70</mark>	Vertical	Pass		
	1	0	Highest	12.71	2.37	10.22	20.56	Vertical	Pass		
	1	0	Lowest	11.14	2.35	10.13	18.92	Horizontal	Pass		
	1	0	Middle	11.13	2.36	10.16	18.93	Horizontal	Pass		
16QAM	1	0	Highest	11.06	2.37	10.22	18.91	Horizontal	Pass		
TOQAIVI	1	0	Lowest	12.48	2.35	10.13	20.26	Vertical	Pass		
	1	0	Middle	12.58	2.36	10.16	<mark>20.38</mark>	Vertical	Pass		
	1	0	Highest	12.5	2.37	10.22	20.35	Vertical	Pass		
Limit		EIRP<1W=30dBm									

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			Radiate	d Power (E	EIRP) for	<sup>r</sup> LTE Ba	and 4 / 20M				
		RΒ				Re	esult				
Modulation	ſ	1D	Channel	S	Cable	Gain	PMeas	Polarization	Conclusion		
	Size	Offset		G.Level (dBm)	loss	(dBi)	E.R.P(dBm)	Of Max. ERP	Conolación		
	1	0	Lowest	11.64	2.35	10.13	19.42	Horizontal	Pass		
	1	0	Middle	11.57	2.36	10.16	19.37	Horizontal	Pass		
QPSK	1	0	Highest	11.42	2.37	10.22	19.27	Horizontal	Pass		
QFOR	1	0	Lowest	13.03	2.35	10.13	<mark>20.81</mark>	Vertical	Pass		
	1	0	Middle	12.88	2.36	10.16	20.68	Vertical	Pass		
	1	0	Highest	12.85	2.37	10.22	20.70	Vertical	Pass		
	1	0	Lowest	11.32	2.35	10.13	19.10	Horizontal	Pass		
	1	0	Middle	11.2	2.36	10.16	19.00	Horizontal	Pass		
16QAM	1	0	Highest	11.2	2.37	10.22	19.05	Horizontal	Pass		
TOQAIVI	1	0	Lowest	12.7	2.35	10.13	<mark>20.48</mark>	Vertical	Pass		
	1	0	Middle	12.62	2.36	10.16	20.42	Vertical	Pass		
	1	0	Highest	12.55	2.37	10.22	20.40	Vertical	Pass		
Limit		EIRP<1W=30dBm									



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# 6. OCCUPIED BANDWIDTH

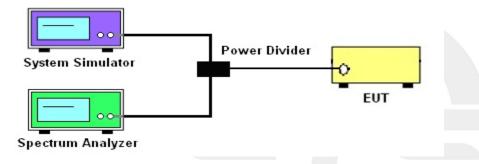
#### 6.1 DESCRIPTION OF OCCUPIED BANDWIDTH MEASUREMENT

#### 6.1.1 MEASUREMENT METHOD

1. The occupied bandwidth is the width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean transmitted power.

2. The 26 db emission bandwidth is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated 26 db below the maximum in-band spectral density of the modulated signal. spectral density (power per unit bandwidth) is to be measured with a detector of resolution bandwidth equal to approximately 1.0% of the emission bandwidth.

#### 6.1.2 TEST SETUP



#### 6.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01 v03r01 Section 4.1.and 4.2
- 2. The EUT was connected to spectrum and system simulator via a power divider
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the Occupied Bandwidth of the spectrum analyzer
- 5. Measure and record the Occupied Bandwidth from the Spectrum Analyzer.

			ព	ΓE		
LTE BW	1.4M	3M	5M	10M	15M	20M
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz
Detector	PK	PK	PK	PK	PK	PK
Trace	Max	Max	Max	Max	Max	Max
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto



# 6.1.4 MEASUREMENT RESULT

# LTE BAND 4

	LTE Band 4 Bandwidth [MHz]								
	Mod	Lowest		Mid	dle	High	nest		
BW [MHz]	IVIOU	26dB BW	99% BW	26dB BW	99% BW	26dB BW	99% BW		
1.4	QPSK	1.262	1.0981	1.327	1.0985	1.328	1.1045		
1.4	16-QAM	1.285	1.0936	1.284	1.1014	1.273	1.1047		
3	QPSK	2.999	2.6902	2.994	2.6865	2.983	2.6893		
3	16-QAM	2.994	2.6853	3.028	2.6859	3.029	2.6888		
5	QPSK	5.199	4.5180	5.372	4.5053	5.340	4.5397		
5	16-QAM	5.315	4.5299	5.429	4.5466	5.410	4.5473		
10	QPSK	9.787	8.9335	9.888	8.9426	9.725	8.9512		
10	16-QAM	9.740	8.9342	9.853	8.9521	10.07	8.9523		
15	QPSK	15.15	13.454	15.87	13.516	15.37	13.504		
15	16-QAM	14.99	13.497	15.19	13.526	15.00	13.514		
20	QPSK	19.56	17.904	19.95	17.973	19.73	17.971		
20	16-QAM	19.86	17.975	19.68	17.949	19.99	17.982		

Note: Test chart See Appendix A

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# 7. CONDUCTED BAND EDGE

#### 7.1 DESCRIPTION OF CONDUCTED BAND EDGE MEASUREMENT

#### 7.1.1 MEASUREMENT METHOD

#### 1. §22.917(a)

For operations in the 824 – 849 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100kHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

#### 2. §24.238 (a)

For operations in the 1850-1910 and 1930-1990 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1MHz bandwidth. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed

#### 3. §27.53 (h)

For operations in the 1710 – 1755 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1 MHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

#### 4. §27.53(m)(4)

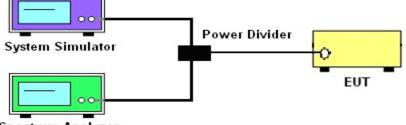
For operations in the 2500 MHz ~ 2570 MHz band this section, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licenseesoperating on frequencies below 2495 MHz may also submit a documented interference complaintagainst BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees.

# 5. §27.53 (g)

For operations in the 698 -746 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100 kHz bandwidth. However, in the 100 kilohertz bands immediately outside and adjacent to a licensee's frequency block, a resolution bandwidth of at least 30 kHz may be employed.



#### 7.1.2 TEST SETUP



Spectrum Analyzer

#### 7.1.3 TEST PROCEDURES

1. The testing FCC KDB 971168 D01 v03r01 Section 6.0. and ANSI C63.26 2015 Section 5.7.

2. The EUT was connected to spectrum analyzer and system simulator via a power divider.

3. The band edges of low and high channels for the highest RF powers were measured. Set RBW >= 1% EBW in the 1MHz band immediately outside and adjacent to the band edge.

4. Set spectrum analyzer with RMS/AVG detector.

5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.

6. The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)

```
= P(W) - [43 + 10log(P)] (dB)
```

```
= [30 + 10\log(P)] (dBm) - [43 + 10\log(P)] (dB)
```

= -13dBm.

Band 7:

- = P(W)- [55 + 10log(P)] (dB)
- $= [30 + 10\log(P)] (dBm) [55 + 10\log(P)] (dB)$

= -25dBm.

		LTE						
LTE BW	1.4M	3M	5M	10M	15M	20M		
Span	12MHz	13MHz	15MHz	20MHz	25MHz	30MHz		
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz		
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz		
Detector	RMS	RMS	RMS	RMS	RMS	RMS		
Trace	Max	Max	Max	Max	Max	Max		
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto		

7.1.4 MEASUREMENT RESULT Note: Test chart See Appendix B



# 8. CONDUCTED SPURIOUS EMISSIO

#### 8.1 DESCRIPTION OF CONDUCTED SPURIOUS EMISSION MEASUREMENT

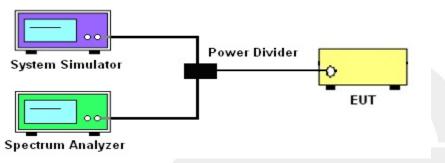
#### 8.1.1 MEASUREMENT METHOD

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7:

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least  $55 + 10 \log (P) dB$ .

It is measured by means of a calibrated spectrum analyzer and scanned from 30 MHz up to a frequency including its 10th harmonic.

#### 8.1.2 TEST SETUP



8.1.3 TEST PROCEDURES

1. The testing FCC KDB 971168 D01 v03r01 Section 6.0. and ANSI C63.26 2015 Section 5.7.

2. The EUT was connected to spectrum analyzer and system simulator via a power divider.

3. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement

4. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.

5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.

6.The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)

= P(W) - [43 + 10log(P)] (dB) = [30 + 10log(P)] (dBm) - [43 + 10log(P)] (dB)

For Band 7: P(W)- [43 + 10log(P)] (dB) =-25dBm

	LTE						
LTE BW	1.4M	3M	5M	10M	15M	20M	
Span	Auto	Auto	Auto	Auto	Auto	Auto	
RBW	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz	
VBW	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz	
Detector	PK	PK	PK	PK	PK	PK	
Trace	Max	Max	Max	Max	Max	Max	

8.1.4 TEST RESULTS Note: Test chart See Appendix C

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#### 9. RADIATED SPURIOUS EMISSION

9.1 DESCRIPTION OF RADIATED SPURIOUS EMISSION

#### 9.1.1 MEASUREMENT METHOD

The radiated spurious emission was measured by substitution method according to ANSI C63.26 2015. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7 The power of any emission outside of the authorized operating frequency ranges must attenuated below the transmitter power (P) by a factor of at least 55 + 10 log (P) dB. The spectrum is scanned from 30 MHz up to a frequency including its 10th harmonic.

#### 9.1.2 TEST SETUP

The procedure of radiated spurious emissions is as follows:

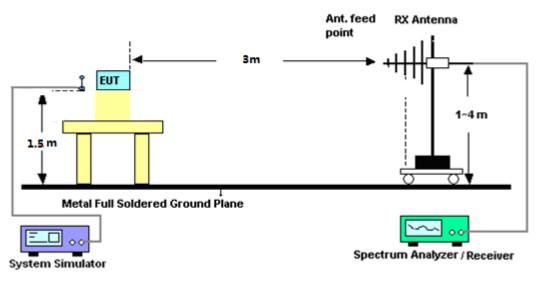
a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx ( dBuV ) +CL ( dB ) +SA ( dB ) +Gain ( dBi ) -107 ( dBuV to dBm ) The SA is calibrated using following setup.

b) EUT was placed on 1.5 m non-conductive stand at a 3 m test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 m from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic measured with peak detector and 1MHz bandwidth.

Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

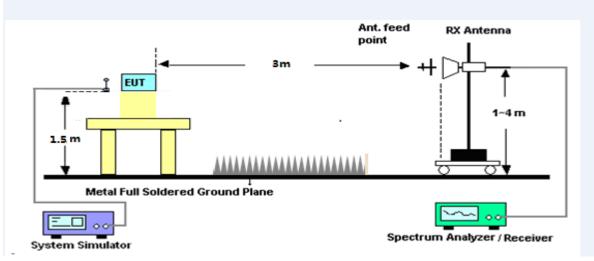
The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below: Power=PMea+ARpl

For radiated test from 30MHz to 1GHz





#### For radiated test from above 1GHz



# 9.1.3 TEST PROCEDURES

1. The testing FCC KDB 971168 D01 Section 5.8 and ANSI C63.26 2015 Section 5.5.

2. The EUT was placed on a rotatable wooden table with 1.5 meter above ground.

3. The EUT was set 3 meters from the receiving antenna, which was mounted on the antenna tower.

4. The table was rotated 360 degrees to determine the position of the highest spurious emission.

5. The height of the receiving antenna is varied between one meter and four meters to search the maximum spurious emission for both horizontal and vertical polarizations

6. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.

7. A horn antenna was substituted in place of the EUT and was driven by a signal generator.

8. Tune the output power of signal generator to the same emission level with EUT maximum spurious emission.

9. Taking the record of output power at antenna port.

10. Repeat step 7 to step 8 for another polarization.

11. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

```
The limit line is derived from 43 + 10\log(P)dB below the transmitter power P(Watts)
= P(W)- [43 + 10log(P)] (dB)
= [30 + 10log(P)] (dBm) - [43 + 10log(P)] (dB)
```

= -13dBm

For Band 7: The limit line is derived from 55 + 10log(P)dB below the transmitter power P(Watts) = [30 + 10log(P)] (dBm) - [55 + 10log(P)] (dB) = -25dBm EIRP (dBm) = S.G. Power – Tx Cable Loss + Tx Antenna Gain ERP (dBm) = EIRP - 2.15



#### 9.1.4 TEST RESULTS

LTE Band 4 / 1.4MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
	S			PMea	Limit	Margin		
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3421.25	-34.25	12.90	12.56	-33.91	-13.00	-20.91	н	
5131.70	-34.17	13.10	12.46	<mark>-33.53</mark>	-13.00	-20.53	н	
6842.65	-32.65	12.33	21.13	-41.45	-13.00	-28.45	н	
3421.25	-35.49	12.90	12.76	-35.35	-13.00	-22.35	V	
5131.70	-35.10	13.10	16.32	-38.32	-13.00	-25.32	V	
6842.65	-31.76	12.33	21.13	-40.56	-13.00	-27.56	V	
LTE Band 4 / 1.	4MHz / QI	PSK / RB Si	ze 1 Offs	et 0/ The V	Norst Test Re	esults for N	liddle	
	S			PMea	Limit	Margin	Delevitu	
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3465.13	-33.86	12.80	12.56	-33.62	-13.00	-20.62	н	
5197.27	-34.08	13.10	12.46	<mark>-33.44</mark>	-13.00	-20.44	н	
6930.09	-33.57	12.33	21.13	-42.37	-13.00	-29.37	Н	
3465.13	-35.06	12.80	12.76	-35.02	-13.00	-22.02	V	
5197.27	-34.88	13.10	16.32	-38.10	-13.00	-25.10	V	
6930.09	-32.25	12.33	21.13	-41.05	-13.00	-28.05	V	
LTE Band 4 / 1.4	4MHz / QF	PSK / RB Siz	ze 1 Offse	et 0/ The V	Vorst Test Re	sults for Hi	ighest	
	S			PMea	Limit	Margin	Delerity	
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3508.62	-33.96	12.61	12.56	<mark>-33.91</mark>	-13.00	-20.91	н	
5262.54	-35.37	13.12	12.46	-34.71	-13.00	-21.71	Н	
7015.93	-33.59	12.32	21.13	-42.40	-13.00	-29.40	Н	
3508.62	-34.99	12.61	12.76	-35.14	-13.00	-22.14	V	
5262.54	-35.20	13.12	16.32	-38.40	-13.00	-25.40	V	
7015.93	-33.14	12.32	21.13	-41.95	-13.00	-28.95	V	

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LTE Band 4 / 3MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
	S			PMea	Limit	Margin	Delevite	
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3424.01	-34.09	12.90	12.56	<mark>-33.75</mark>	-13.00	-20.75	н	
5136.33	-35.03	13.10	12.46	-34.39	-13.00	-21.39	н	
6848.71	-32.76	12.33	21.13	-41.56	-13.00	-28.56	н	
3424.01	-34.63	12.90	12.76	-34.49	-13.00	-21.49	V	
5136.33	-34.42	13.10	16.32	-37.64	-13.00	-24.64	V	
6848.71	-31.76	12.33	21.13	-40.56	-13.00	-27.56	V	
LTE Band 4 / 3	BMHz / QP	SK / RB Siz	e 1 Offse	t 0/ The W	orst Test Re	sults for Mi	ddle	
	S	A pt(dDi)		PMea	Limit	Margin		
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3465.15	-34.37	12.80	12.56	-34.13	-13.00	-21.13	н	
5197.16	-34.64	13.10	12.46	<mark>-34.00</mark>	-13.00	-21.00	Н	
6930.02	-33.57	12.33	21.13	-42.37	-13.00	-29.37	Н	
3465.15	-35.20	12.80	12.76	-35.16	-13.00	-22.16	V	
5197.16	-35.08	13.10	16.32	-38.30	-13.00	-25.30	V	
6930.02	-31.89	12.33	21.13	-40.69	-13.00	-27.69	V	
LTE Band 4 / 3	MHz / QP	SK / RB Size	e 1 Offset	t 0/ The W	orst Test Res	sults for Hig	phest	
	S G.Lev	Apt(dDi)		PMea	Limit	Margin	Delority	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3506.70	-34.86	12.61	12.56	-34.81	-13.00	-21.81	Н	
5262.11	-35.32	13.12	12.46	<mark>-34.66</mark>	-13.00	-21.66	н	
7012.91	-32.76	12.32	21.13	-41.57	-13.00	-28.57	н	
3506.70	-35.76	12.61	12.76	-35.91	-13.00	-22.91	V	
5262.11	-34.25	13.12	16.32	-37.45	-13.00	-24.45	V	
7012.91	-31.74	12.32	21.13	-40.55	-13.00	-27.55	V	

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LTE Band 4 / 5MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
	S			PMea	Limit	Margin	Dalarita	
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3425.24	-34.48	12.90	12.56	-34.14	-13.00	-21.14	Н	
5137.22	-34.30	13.10	12.46	<mark>-33.66</mark>	-13.00	-20.66	Н	
6850.24	-33.36	12.33	21.13	-42.16	-13.00	-29.16	Н	
3425.24	-35.06	12.90	12.76	-34.92	-13.00	-21.92	V	
5137.22	-34.48	13.10	16.32	-37.70	-13.00	-24.70	V	
6850.24	-31.72	12.33	21.13	-40.52	-13.00	-27.52	V	
LTE Band 4 / S	5MHz / QP	SK / RB Siz	e 1 Offse	t 0/ The W	orst Test Re	sults for Mi	ddle	
	S G.Lev	Apt(dBi)		PMea	Limit	Margin	Polarity	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	1 Olarity	
3465.03	-34.06	12.80	12.56	<mark>-33.82</mark>	-13.00	-20.82	Н	
5196.83	-34.75	13.10	12.46	-34.11	-13.00	-21.11	Н	
6929.99	-33.36	12.33	21.13	-42.16	-13.00	-29.16	Н	
3465.03	-35.46	12.80	12.76	-35.42	-13.00	-22.42	V	
5196.83	-34.04	13.10	16.32	-37.26	-13.00	-24.26	V	
6929.99	-31.84	12.33	21.13	-40.64	-13.00	-27.64	V	
LTE Band 4 / 5	MHz / QP	SK / RB Size	e 1 Offset	t 0/ The W	orst Test Res	sults for Hig	phest	
	S G.Lev	Apt(dBi)		PMea	Limit	Margin	Delority	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3505.46	-34.38	12.61	12.56	<mark>-34.33</mark>	-13.00	-21.33	Н	
5257.14	-35.42	13.12	12.46	-34.76	-13.00	-21.76	Н	
7009.96	-32.17	12.32	21.13	-40.98	-13.00	-27.98	Н	
3505.46	-34.60	12.61	12.76	-34.75	-13.00	-21.75	V	
5257.14	-34.89	13.12	16.32	-38.09	-13.00	-25.09	V	
7009.96	-31.78	12.32	21.13	-40.59	-13.00	-27.59	V	

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LTE Band 4 / 10MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
	S			PMea	Limit	Margin	Delevite	
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity	
3430.14	-33.84	12.90	12.56	<mark>-33.50</mark>	-13.00	-20.50	Н	
5145.23	-35.09	13.10	12.46	-34.45	-13.00	-21.45	Н	
6860.51	-33.63	12.33	21.13	-42.43	-13.00	-29.43	Н	
3430.14	-35.19	12.90	12.76	-35.05	-13.00	-22.05	V	
5145.23	-34.47	13.10	16.32	-37.69	-13.00	-24.69	V	
6860.51	-32.29	12.33	21.13	-41.09	-13.00	-28.09	V	
LTE Band 4 / 1	0MHz / QF	PSK / RB Siz	ze 1 Offse	et 0/ The V	Vorst Test Re	esults for M	iddle	
	S G.Lev	Apt(dBi)	Loss	PMea	Limit	Margin	Polarity	
Frequency(MHz)	(dBm)	Ant(dBi)	LUSS	(dBm)	(dBm)	(dBm)	Тоганту	
3464.98	-34.35	12.80	12.56	<mark>-34.11</mark>	-13.00	-21.11	Н	
5197.27	-34.98	13.10	12.46	-34.34	-13.00	-21.34	Н	
6929.94	-32.73	12.33	21.13	-41.53	-13.00	-28.53	Н	
3464.98	-34.62	12.80	12.76	-34.58	-13.00	-21.58	V	
5197.27	-34.64	13.10	16.32	-37.86	-13.00	-24.86	V	
6929.94	-33.08	12.33	21.13	-41.88	-13.00	-28.88	V	
LTE Band 4 / 10	)MHz / QP	SK / RB Siz	e 1 Offse	t 0/ The W	/orst Test Re	sults for Hi	ghest	
Frequency(MHz)	S G.Lev	Apt(dBi)	Loss	PMea	Limit	Margin	Polarity	
Frequency(initz)	(dBm)	Ant(dBi)	L055	(dBm)	(dBm)	(dBm)	Folanty	
3500.82	-34.81	12.61	12.56	-34.76	-13.00	-21.76	Н	
5250.39	-35.23	13.12	12.46	<mark>-34.57</mark>	-13.00	-21.57	Н	
7000.23	-33.64	12.32	21.13	-42.45	-13.00	-29.45	Н	
3500.82	-35.76	12.61	12.76	-35.91	-13.00	-22.91	V	
5250.39	-35.03	13.12	16.32	-38.23	-13.00	-25.23	V	
7000.23	-32.25	12.32	21.13	-41.06	-13.00	-28.06	V	

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LTE Band 4 / 1	LTE Band 4 / 15MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
	S			PMea	Limit	Margin	Delevity		
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3435.20	-34.58	12.90	12.56	<mark>-34.24</mark>	-13.00	-21.24	н		
5152.24	-35.46	13.10	12.46	-34.82	-13.00	-21.82	н		
6870.71	-32.91	12.33	21.13	-41.71	-13.00	-28.71	н		
3435.20	-35.50	12.90	12.76	-35.36	-13.00	-22.36	V		
5152.24	-35.06	13.10	16.32	-38.28	-13.00	-25.28	V		
6870.71	-32.58	12.33	21.13	-41.38	-13.00	-28.38	V		
LTE Band 4 / 1	5MHz / QF	PSK / RB Siz	ze 1 Offse	et 0/ The V	Vorst Test Re	sults for M	iddle		
	S G.Lev			PMea	Limit	Margin	Delerity		
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3464.86	-33.74	12.80	12.56	<mark>-33.50</mark>	-13.00	-20.50	н		
5197.16	-35.27	13.10	12.46	-34.63	-13.00	-21.63	н		
6929.82	-32.58	12.33	21.13	-41.38	-13.00	-28.38	н		
3464.86	-34.53	12.80	12.76	-34.49	-13.00	-21.49	V		
5197.16	-35.23	13.10	16.32	-38.45	-13.00	-25.45	V		
6929.82	-31.86	12.33	21.13	-40.66	-13.00	-27.66	V		
LTE Band 4 / 15	5MHz / QP	SK / RB Siz	e 1 Offse	t 0/ The W	/orst Test Re	sults for Hi	ghest		
	S			PMea	Limit	Margin	Delerity		
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity		
3495.73	-34.93	12.61	12.56	-34.88	-13.00	-21.88	Н		
5242.17	-34.04	13.12	12.46	<mark>-33.38</mark>	-13.00	-20.38	Н		
6990.58	-33.59	12.32	21.13	-42.40	-13.00	-29.40	н		
3495.73	-35.74	12.61	12.76	-35.89	-13.00	-22.89	V		
5242.17	-34.40	13.12	16.32	-37.60	-13.00	-24.60	V		
6990.58	-32.12	12.32	21.13	-40.93	-13.00	-27.93	V		

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LTE Band 4 / 20MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest							
Frequency(MHz)	S G.Lev	Ant(dBi)	Loss	PMea	Limit	Margin	Polarity
	(dBm)	/ in(dbi)	2000	(dBm)	(dBm)	(dBm)	Tolarity
3440.14	-33.57	12.90	12.56	<mark>-33.23</mark>	-13.00	-20.23	н
5160.58	-34.32	13.10	12.46	-33.68	-13.00	-20.68	Н
6880.72	-32.76	12.33	21.13	-41.56	-13.00	-28.56	Н
3440.14	-34.98	12.90	12.76	-34.84	-13.00	-21.84	V
5160.58	-33.86	13.10	16.32	-37.08	-13.00	-24.08	V
6880.72	-32.70	12.33	21.13	-41.50	-13.00	-28.50	V
LTE Band 4 / 2	0MHz / QF	PSK / RB Siz	ze 1 Offse	et 0/ The V	Vorst Test Re	sults for M	iddle
	S			PMea	Limit	Margin	Dalarita
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3465.06	-33.91	12.80	12.56	<mark>-33.67</mark>	-13.00	-20.67	Н
5197.21	-34.97	13.10	12.46	-34.33	-13.00	-21.33	Н
6930.09	-33.05	12.33	21.13	-41.85	-13.00	-28.85	Н
3465.06	-35.98	12.80	12.76	-35.94	-13.00	-22.94	V
5197.21	-34.26	13.10	16.32	-37.48	-13.00	-24.48	V
6930.09	-32.08	12.33	21.13	-40.88	-13.00	-27.88	V
LTE Band 4 / 20	) MHz / QP	SK / RB Siz	e 1 Offse	t 0/ The W	/orst Test Re	sults for Hi	ghest
	S			PMea	Limit	Margin	
Frequency(MHz)	G.Lev (dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dBm)	Polarity
3490.55	-34.85	12.61	12.56	-34.80	-13.00	-21.80	Н
5235.30	-34.12	13.12	12.46	<mark>-33.46</mark>	-13.00	-20.46	Н
6979.92	-33.45	12.32	21.13	-42.26	-13.00	-29.26	Н
3490.55	-35.55	12.61	12.76	-35.70	-13.00	-22.70	V
5235.30	-34.18	13.12	16.32	-37.38	-13.00	-24.38	V
6979.92	-32.77	12.32	21.13	-41.58	-13.00	-28.58	V

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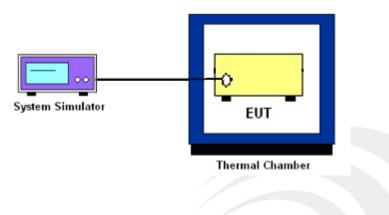
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# 10. FREQUENCY STABILITY 10.1 DESCRIPTION OF FREQUENCY STABILITY MEASUREMENT

#### 10.1.1 MEASUREMENT METHOD

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within  $\pm 0.00025\%$  ( $\pm 2.5$ ppm) of the center frequency.

#### 10.1.2 TEST SETUP



#### 10.1.3 TEST PROCEDURES FOR TEMPERATURE VARIATION

1. The EUT was set up in the thermal chamber and connected with the system simulator.

With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute.
 With power OFF, the temperature was raised in 10°C step up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute.

# 10.1.4 TEST PROCEDURES FOR VOLTAGE VARIATION

1. The testing follows FCC KDB 971168 D01v01r03 Section 9.0.

2. The EUT was placed in a temperature chamber at 25±5° C and connected with the system simlator.

3. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.

4. The variation in frequency was measured for the worst case.



# 10.1.5 TEST RESULTS

	LTE Band 4 (Q	PSK) / 1733	MHz / BW10	M	
Temperature (°C)	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result
	(Volt)	(Hz)	(ppm)		
50		31.64	0.018		
40		24.42	0.014		
30		20.34	0.012		
20		34.04	0.020		
10	Normal Voltage	21.63	0.012		
0		30.78	0.018	2.5ppm	PASS
-10		30.34	0.018	21000	
-20		33.37	0.019		
-30		16.50	0.010		
25	Maximum Voltage	19.80	0.011		
25	BEP	18.18	0.010		

	LTE Band 4 (QPSK) / 1733MHz / BW20M							
Temperature (°C)	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result			
,	(Volt)	(Hz)	(ppm)					
50		25.39	0.015					
40		18.04	0.010					
30		27.52	0.016					
20		28.73	0.017	_				
10	Normal Voltage	29.45	0.017					
0		29.72	0.017	2.5ppm	PASS			
-10	]	29.27	0.017	2.000	17,00			
-20		31.58	0.018					
-30	]	23.21	0.013					
25	Maximum Voltage	11.86	0.007					
25	BEP	26.08	0.015					

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# APPENDIX-PHOTOS OF TEST SETUP

Note: See test photos in setup photo document for the actual connections between Product and support equipment.

\* \* \* \* \* END OF THE REPORT \* \* \* \* \*



Shenzhen STS Test Services Co., Ltd.